3.3V Differential 1:21 Fanout Clock and Data Driver with HCSL Outputs

Description

The NB3N121K is a differential 1:21 Clock and Data fanout buffer with High-speed Current Steering Logic (HCSL) outputs optimized for ultra low propagation delay variation. The NB3N121K is designed with HCSL PCI Express clock distribution and FBDIMM applications in mind.

Inputs can directly accept differential LVPECL, HCSL, and LVDS signals per Figures 7, 8, and 9. Single ended LVPECL, HCSL, LVCMOS, or LVTTL levels are accepted with a proper external V_{th} reference supply per Figures 4 and 10. Input pins incorporate separate internal 50 Ω termination resistors allowing additional single ended system interconnect flexibility.

Output drive current is set by connecting a 475 Ω resistor from IREF (Pin 1) to GND per Figure 6. Outputs can also interface to LVDS receivers when terminated per Figure 11.

The NB3N121K specifically guarantees low output-to-output skew. Optimal design, layout, and processing minimize skew within a device and from device to device. System designers can take advantage of the NB3N121K's performance to distribute low skew clocks across the backplane or the motherboard.

Features

- Typical Input Clock Frequency 100, 133, 166, 200, 266, 333 and 400 MHz
- 340 ps Typical Rise and Fall Times
- 800 ps Typical Propagation Delay
- 100 ps Max Within Device Skew
- 150 ps Max Device-to-Device Skew
- Δtpd 100 ps Maximum Propagation Delay Variation Per Each Differential Pair
- 0.1 ps Typical RMS Additive Phase Jitter
- LVDS Output Levels Optional with Interface Termination
- Operating Range: $V_{CC} = 3.0 \text{ V}$ to 3.6 V with GND = 0 V
- Typical HCSL Output Level (700 mV Peak-to-Peak)
- These are Pb-Free Devices

Applications

- Clock Distribution
- PCIe I, II, III
- Networking
- High End Computing
- Routers

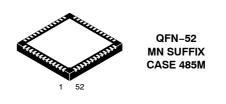
End Products

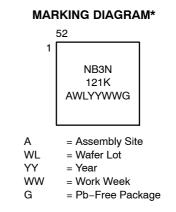
- Servers
- FBDIMM Memory Card

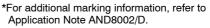


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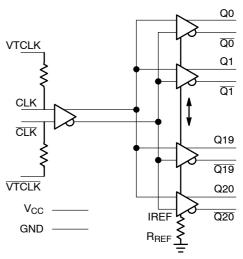


Figure 1. Simplified Logic Diagram

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 10 of this data sheet.

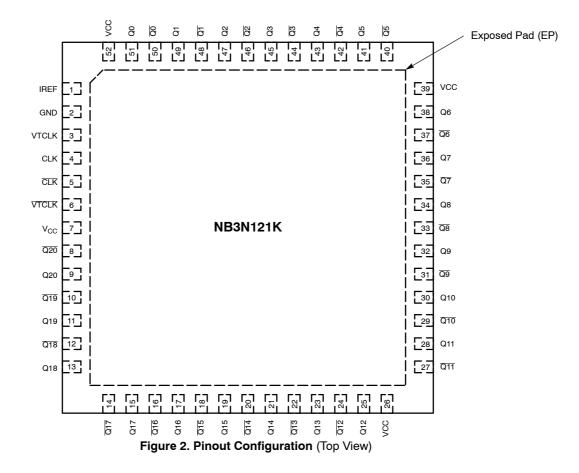


Table 1. PIN DESCRIPTION

| Pin | Name | I/O | Description |
|---|-----------------|--|---|
| 1 | IREF | Output | Use the IREF pin to set the output drive. Connect a 475 Ω RREF resistor from the IREF pin to GND to produce 2.63 mA of IREF current. A current mirror multiplies IREF by a factor of 5.4 to force 14.2 mA through a 50 Ω output load. See Figures 6 and 12. Minimize capacitance. |
| 2 | GND | _ | Supply Ground. GND pin must be externally connected to power supply to guarantee proper operation. |
| 3, 6 | VTCLK, VTCLK | - | Internal 50 Ω Termination Resistor connection Pins. In the differential configuration when the input termination pins are connected to the common termination voltage, and if no signal is applied then the device may be susceptible to self-oscillation. |
| 4 | CLK | LVPECL, HCSL, LVCMOS or LVTTL Input | Clock (TRUE) Input |
| 5 | CLK | LVPECL, HCSL, LVCMOS or LVTTL Input | Clock (INVERT) Input |
| 7, 26, 39, 52 | VCC | _ | Positive Supply pins. VCC pins must be externally connected to a power supply to guarantee proper operation. |
| 8, 10, 12, 14, 16, 18, 20, 22, 24, 27, 29, 31, 33, 35, 37, 40,42, 44, 46, 48, 50 | <u>Q[20–0]</u> | HCSL or LVDS (Note 1) Output | Output (INVERT) (Note 1) |
| 9, 11, 13, 15, 17, 19, 21, 23, 25, 28, 30, 32, 34, 36, 38, 41, 43, 45, 47, 49, 51 | Q[20-0] | HCSL or LVDS (Note 1) Output | |
| Exposed Pad | EP | GND | Exposed Pad. The thermally exposed pad (EP) on package bottom (see case drawing) must be attached to a sufficient heat-sinking conduit for proper thermal operation. The pad is electrically connected ot GND and must be connected to GND on the PC board. |

1. Outputs can also interface to LVDS receiver when terminated per Figure 11.

Table 2. ATTRIBUTES

| Characteri | Value | | | |
|--|-----------------------------------|----------------------|--|--|
| ESD Protection | Human Body Model Machine Model | >2 kV 200 V | | |
| Moisture Sensitivity (Note 2) | QFN-52 | Level 1 | | |
| Flammability Rating | Oxygen Index: 28 to 34 | UL 94 V–0 @ 0.125 in | | |
| Transistor Count | 409 | | | |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test | | | | |

2. For additional information, see Application Note AND8003/D.

Table 3. MAXIMUM RATINGS (Note 3)

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
|----------------------|---|---------------------|------------------|----------------------------------|--------------|
| V _{CC} | Positive Power Supply | GND = 0 V | | 4.6 | V |
| VI | Positive Input | GND = 0 V | | $GND-0.3 \leq V_{I} \leq V_{CC}$ | V |
| I _{OUT} | Output Current | Continuous Surge | | 50 100 | mA mA |
| T _A | Operating Temperature Range | QFN-52 | | -40 to +85 | °C |
| T _{stg} | Storage Temperature Range | | | -65 to +150 | °C |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) (Note 3) | 0 lfpm 500 lfpm | QFN-52 QFN-52 | 25 19.6 | °C/W °C/W |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | 2S2P (Note 4) | QFN-52 | 21 | °C/W |
| T _{sol} | Wave Solder Pb-Free | | | 265 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.
3. JEDEC standard 51–6, multilayer board – 2S2P (2 signal, 2 power).
4. JEDEC standard multilayer board – 2S2P (2 signal, 2 power) with 8 filled thermal vias under exposed pad.

Table 4. DC CHARACTERISTICS (V_{CC} = 3.0 V to 3.6 V, $T_A = -40^{\circ}C$ to +85°C Note 5)

| Symbol | Characteristic | Min | Тур | Max | Unit |
|--|--|-----------------------|------|------------------------|------|
| I _{GND} | GND Supply Current (All Outputs Loaded) | | 120 | 150 | mA |
| I _{CC} | Power Supply Current (All Outputs Loaded) | | 440 | 500 | mA |
| Ι _{ΙΗ} | Input HIGH Current | | 2.0 | 150 | μA |
| ۱ _{IL} | Input LOW Current | -150 | -2.0 | | μA |
| R _{TIN} | Internal Input Termination Resistor | 45 | 50 | 55 | Ω |
| DIFFERENTIAL INPUT DRIVEN SINGLE - ENDED (See Figures 4 and 5) | | | | | |
| V _{th} | Input Threshold Reference Voltage Range (Note 6) | 350 | | V _{CC} – 1000 | mV |
| VIH | Single-Ended Input HIGH Voltage | V _{th} + 150 | | V _{CC} | mV |

V_{IL} Single-Ended Input LOW Voltage

DIFFERENTIAL INPUTS DRIVEN DIFFERENTIALLY (Figures 7, 8 and 9)

| V _{IHD} | Differential Input HIGH Voltage | 425 | V _{CC} – 850 | mV |
|------------------|---|-----|------------------------|----|
| V _{ILD} | Differential Input LOW Voltage | GND | V _{CC} – 1000 | mV |
| V _{ID} | Differential Input Voltage (V _{IHD} – V _{ILD}) | 150 | V _{CC} – 850 | mV |
| V _{CMR} | Input Common Mode Range | 350 | V _{CC} – 1000 | mV |

GND

V_{th} – 150

mV

HCSL OUTPUTS (Figure 4)

| V _{OL} Output LOW Voltage -150 0 150 mV | V _{OH} | Output HIGH Voltage | 600 | 740 | 900 | mV |
|--|-----------------|---------------------|------|-----|-----|----|
| | V _{OL} | Output LOW Voltage | -150 | 0 | 150 | mV |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit

values are applied individually under normal operating conditions and not valid simultaneously. 5. Measurements taken with with outputs loaded 50 Ω to GND. Connect a 475 Ω resister from IREF (Pin 1) to GND. See Figure 6.

V_{th} is applied to the complementary input when operating in single ended mode per Figure 4.

| Symbol | Characteristic | Min | Тур | Max | Unit |
|--|---|-------|-----|--------------------------|------|
| V _{OUTPP} | Output Voltage Amplitude (@ $V_{INPPmin}$) f _{in} \leq 400 MHz | | 725 | 1000 | mV |
| t _{PLH} , t _{PHL} | Propagation Delay (See Figure 3a) CLK/CLK to Qx/Q | 550 | 800 | 950 | ps |
| $\Delta t_{PLH}, \\ \Delta t_{PHL}$ | Propagation Delay Variations Per Each Diff Pair (Note 8) (See Figure 3a) CLK/CLK to Qx/Q | ī | | 100 | ps |
| t _{SKEW} | Duty Cycle Skew (Note 9) Within -Device Skew Device to Device Skew (Note 10) | | | 20 100 150 | ps |
| ţлт | Additive RMS Phase Jitter (Note 11) F _{in} = 100 MHz | | 0.1 | | ps |
| V _{INPP} | Input Voltage Swing/Sensitivity (Differential Configuration) | 150 | | V _{CC} - 850 | mV |
| V _{CROSS} | Absolute Crossing Magnitude Voltage (See Figure 3c) | 250 | | 550 | mV |
| ΔV_{CROSS} | Variation in Magnitude of V _{CROSS} (See Figure 3c) | | | 150 | mV |
| t _r , t _f | Absolute Magnitude in Output Risetime and Falltime (from 175 mV to 525 mV) (See Figure 3b) Qx, \overline{Q} | ā 100 | 340 | 700 | ps |
| Δtr , Δtf | Variation in Magnitude of Risetime and Falltime (Single-Ended) (See Figure 3b) Qx, \overline{Q} | C . | | 125 | ps |

Table 5. AC CHARACTERISTICS V_{CC} = 3.0 V to 3.6 V, GND = 0 V; -40° C to $+85^{\circ}$ C (Note 7)

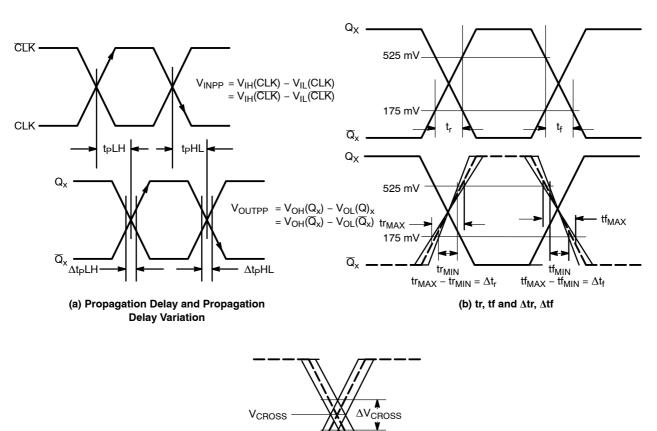
NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

7. Measured by forcing V_{INPP} (MIN) from a 50% duty cycle clock source. Connect a 475 Ω resister from IREF (Pin 1) to GND. All outputs loaded 50 Ω to GND per Figure 6.

Measured from the input pair crosspoint to each single output pair crosspoint across temp and voltage ranges per Figure 3.
 Duty cycle skew is measured between differential outputs using the deviations of the sum of Tpw- and Tpw+.

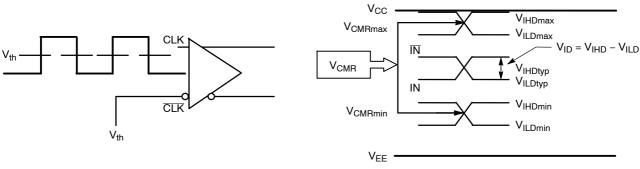
10. Skew is measured between outputs under identical conditions @ 50 MHz.

11. Phase noise integrated from 12 kHz to 20 MHz



(c) VCROSS and ΔVCROSS





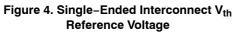
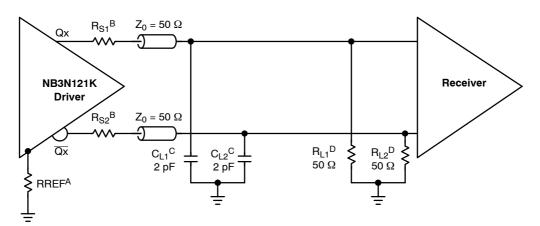


Figure 5. V_{th} Diagram



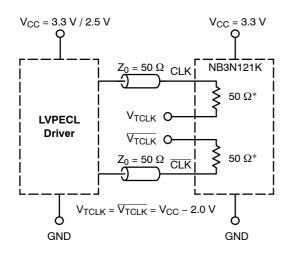
A. Connect 475 Ω resistor RREF from IREF pin to GND.

B. R_{S1} , R_{S2} : 0 Ω for Test and Evaluation. Select to Minimizing Ringing.

C. CL1, CL2: Receiver Input Simulation (for test only not added to application circuit.

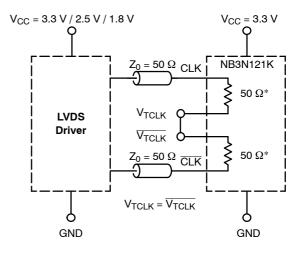
D. R_{L1}, R_{L2} Termination and Load Resistors Located at Receiver Inputs.





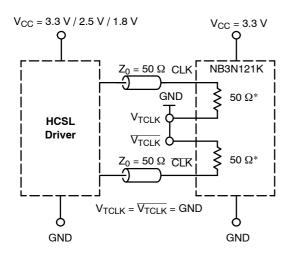
*RTIN, Internal Input Termination Resistor

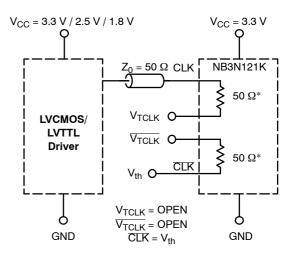
Figure 7. LVPECL Interface



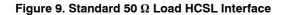
*RTIN, Internal Input Termination Resistor

Figure 8. LVDS Interface





*RTIN, Internal Input Termination Resistor



*RTIN, Internal Input Termination Resistor

Figure 10. LVCMOS/LVTTL Interface

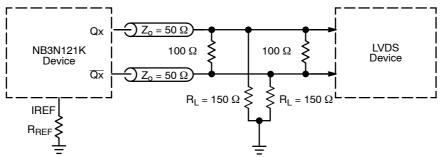


Figure 11. HCSL Interface Termination to LVDS

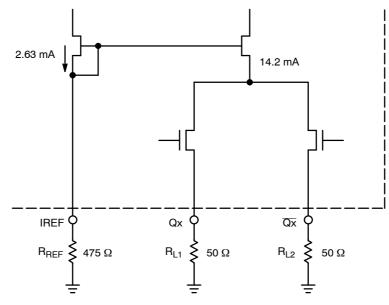


Figure 12. Simplified HCSL Output Structure

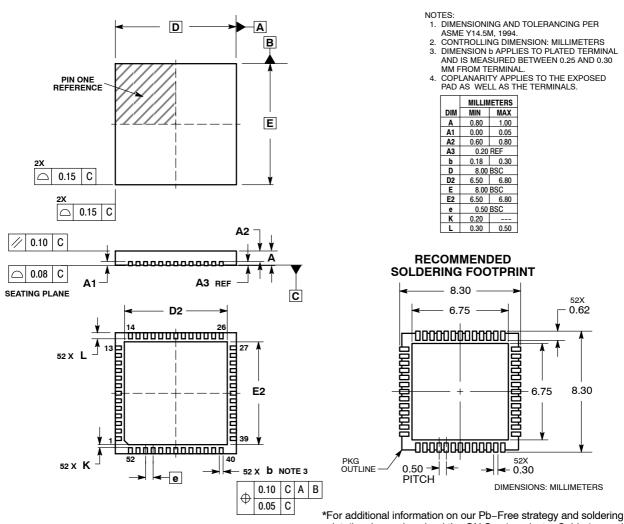
ORDERING INFORMATION

| Device | Package | Shipping [†] |
|---------------|---------------------|-----------------------|
| NB3N121KMNG | QFN-52 (Pb-Free) | 260 Units / Tray |
| NB3N121KMNR2G | QFN-52 (Pb-Free) | 2000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

QFN52 8x8, 0.5P CASE 485M-01 ISSUE C



details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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